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| Notice of References Cited | Application/Control No. 10/527,528 | | Applicant(s)/Patent Under Reexamination TSUBOUCHI ET AL. | |
| | Examiner Ellen M. McAvoy | | Art Unit 1797 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-4,871,476 | 10-1989 | Yoshimura et al. | 508/505 |
| * | B | US-4,889,649 | 12-1989 | Murai et al. | 252/73 |
| * | C | US-5,126,065 | 06-1992 | Tsubouchi et al. | 508/591 |
| * | D | US-5,283,384 | 02-1994 | Abe et al. | 585/22 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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